Preferred Device

General Purpose Transistors

PNP Silicon

Features

• Pb-Free Packages are Available*



Rating	Symbol	Value	Unit
Collector - Emitter Voltage	V _{CEO}	40	Vdc
Collector - Base Voltage	V _{CBO}	40	Vdc
Emitter – Base Voltage	Emitter – Base Voltage V _{EBO} 5.0		Vdc
Collector Current – Continuous	I _C	200	mAdc
Total Device Dissipation @ T _A = 25°C Derate above 25°C	P _D	625 5.0	mW mW/°C
Total Power Dissipation @ T _A = 60°C	P _D	250	mW 🦠
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	1.5 12	W mW/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-55 to +150	°C

THERMAL CHARACTERISTICS (Note 1)

Characteristic		Symbol	Max	Unit
Thermal Resistance, Junction-to-A	$R_{\theta JA}$	200	°C/W	
Thermal Resistance, Junction-to	-Case	$R_{\theta JC}$	83.3	°C/W

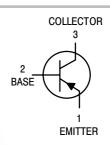
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Indicates Data in addition to JEDEC Requirements.



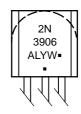
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MARKING DIAGRAM



A = Assembly Location

L = Wafer Lot

Y = Year

W = Work Week

= Pb-Free Package(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

	Symbol	Min	Max	Unit		
OFF CHARACTERISTI	cs					
Collector – Emitter Breakdown Voltage (Note 2) $(I_C = 1.0 \text{ mAdc}, I_B =$		(l _C = 1.0 mAdc, l _B = 0)	V _{(BR)CEO}	40	_	Vdc
Collector - Base Breakd	lown Voltage	$(I_C = 10 \mu Adc, I_E = 0)$	V _{(BR)CBO}	40	_	Vdc
Emitter – Base Breakdo	wn Voltage	$(I_E = 10 \mu Adc, I_C = 0)$	V _{(BR)EBO}	5.0	_	Vdc
Base Cutoff Current		(V _{CE} = 30 Vdc, V _{EB} = 3.0 Vdc)	I _{BL}	-	50	nAdc
Collector Cutoff Current	t	(V _{CE} = 30 Vdc, V _{EB} = 3.0 Vdc)	I _{CEX}	-	50	nAdc
ON CHARACTERISTIC	S (Note 2)					
DC Current Gain		$ \begin{array}{l} (I_{C}=0.1 \text{ mAdc}, V_{CE}=1.0 \text{ Vdc}) \\ (I_{C}=1.0 \text{ mAdc}, V_{CE}=1.0 \text{ Vdc}) \\ (I_{C}=10 \text{ mAdc}, V_{CE}=1.0 \text{ Vdc}) \\ (I_{C}=50 \text{ mAdc}, V_{CE}=1.0 \text{ Vdc}) \\ (I_{C}=100 \text{ mAdc}, V_{CE}=1.0 \text{ Vdc}) \end{array} $	h _{FE}	60 80 100 60 30	300 - -	-
Collector - Emitter Saturation Voltage		$(I_C = 10 \text{ mAdc}, I_B = 1.0 \text{ mAdc})$ $(I_C = 50 \text{ mAdc}, I_B = 5.0 \text{ mAdc})$	V _{CE(sat)}	_ _	0.25 0.4	Vdc
Base – Emitter Saturation Voltage		$(I_C = 10 \text{ mAdc}, I_B = 1.0 \text{ mAdc})$ $(I_C = 50 \text{ mAdc}, I_B = 5.0 \text{ mAdc})$	V _{BE(sat)}	0.65 -	0.85 0.95	Vdc
SMALL-SIGNAL CHA	RACTERISTICS		3 15			•
Current-Gain - Bandw	ridth Product ($I_C = 10 \text{ mAdc}, V_{CE} = 20 \text{ Vdc}, f = 100 \text{ MHz})$	f	250	_	MHz
Output Capacitance		$(V_{CB} = 5.0 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz})$	C _{obo}	_	4.5	pF
Input Capacitance		$(V_{EB} = 0.5 \text{ Vdc}, I_C = 0, f = 1.0 \text{ MHz})$	C _{ibo}	-	10	pF
Input Impedance		$(I_C = 1.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, f = 1.0 \text{ kHz})$	h _{ie}	2.0	12	kΩ
Voltage Feedback Ratio		$(I_C = 1.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, f = 1.0 \text{ kHz})$	h _{re}	0.1	10	X 10 ⁻
Small-Signal Current Gain		$(I_C = 1.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, f = 1.0 \text{ kHz})$	h _{fe}	100	400	-
Output Admittance		$(I_C = 1.0 \text{ mAdc}, V_{CE} = 10 \text{ Vdc}, f = 1.0 \text{ kHz})$	h _{oe}	3.0	60	μmhos
Noise Figure	$(I_C = 100 \mu Ad)$	c, $V_{CE} = 5.0 \text{ Vdc}$, $R_{S} = 1.0 \text{ k}\Omega$, $f = 1.0 \text{ kHz}$)	NF	-	4.0	dB
SWITCHING CHARAC	TERISTICS					
Delay Time	(V _{CC} = 3.0 Vdc, V _{BE} = 0.5 Vdc,		t _d	_	35	ns
Rise Time	$I_C = 10 \text{ mAdc}, I_{B1} =$	= 1.0 mAdc)	t _r	-	35	ns
Storage Time	$(V_{CC} = 3.0 \text{ Vdc}, I_{C} = 10 \text{ mAdc}, I_{B1} = I_{B2} = 1.0 \text{ mAdc})$		ts	-	225	ns
Fall Time	II Time $(V_{CC} = 3.0 \text{ Vdc}, I_C = 10 \text{ mAdc}, I_{B1} = I_{B2} = 1.0 \text{ mAdc})$		t _f	_	75	ns

ORDERING INFORMATION

Device	Package	Shipping [†]	
2N3906	TO-92	5000 Units / Bulk	
2N3906G	TO-92 (Pb-Free)	5000 Units / Bulk	
2N3906RL1	TO-92	5000 Units / Bulk	
2N3906RL1G	TO-92 (Pb-Free)	5000 Units / Bulk	
2N3906RLRA	TO-92	2000 / Tape & Reel	
2N3906RLRAG	TO-92 (Pb-Free)	2000 / Tape & Reel	
2N3906RLRM	TO-92	2000 / Ammo Pack	
2N3906RLRMG	TO-92 (Pb-Free)	2000 / Ammo Pack	
2N3906RLRP	TO-92	2000 / Tape & Reel	
2N3906RLRPG	TO-92 (Pb-Free)		

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

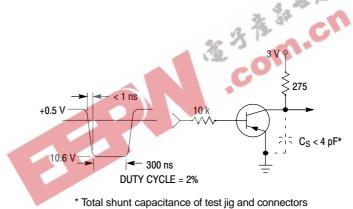
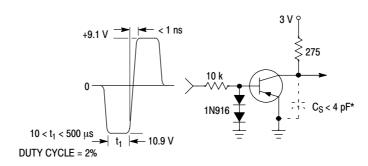


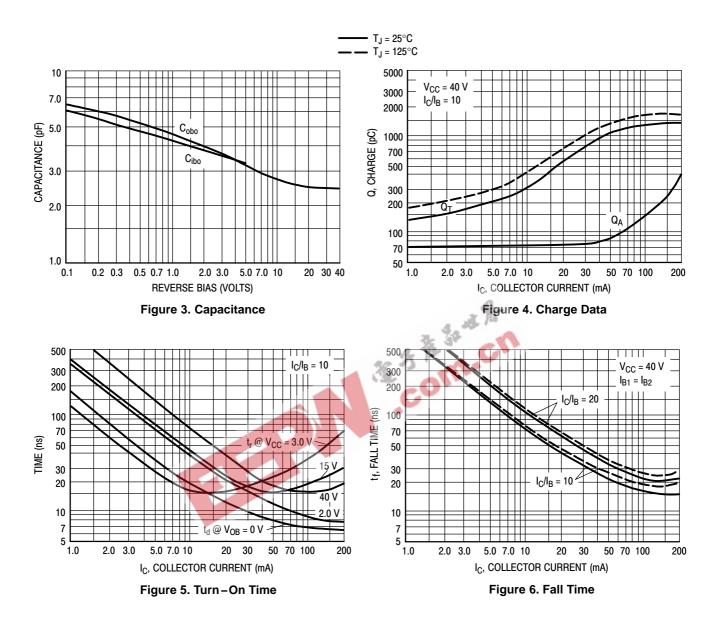
Figure 1. Delay and Rise Time Equivalent Test Circuit



^{*} Total shunt capacitance of test jig and connectors

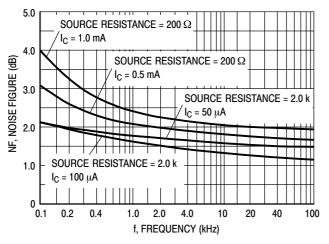
Figure 2. Storage and Fall Time Equivalent Test Circuit

TYPICAL TRANSIENT CHARACTERISTICS



TYPICAL AUDIO SMALL-SIGNAL CHARACTERISTICS NOISE FIGURE VARIATIONS

 $(V_{CE} = -5.0 \text{ Vdc}, T_A = 25^{\circ}\text{C}, Bandwidth = 1.0 \text{ Hz})$



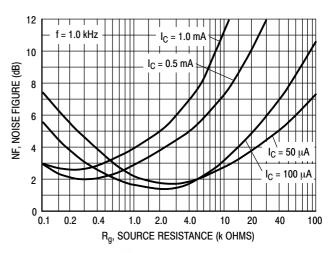


Figure 7.

Figure 8.

h PARAMETERS

 $(V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}, T_A = 25^{\circ}\text{C}$

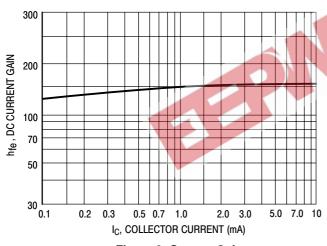
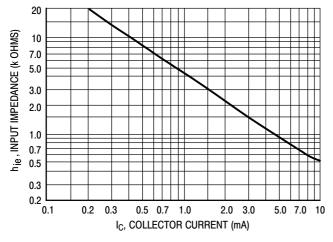




Figure 9. Current Gain

Figure 10. Output Admittance



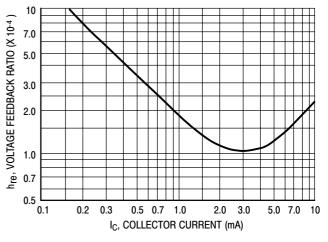


Figure 11. Input Impedance

Figure 12. Voltage Feedback Ratio

TYPICAL STATIC CHARACTERISTICS

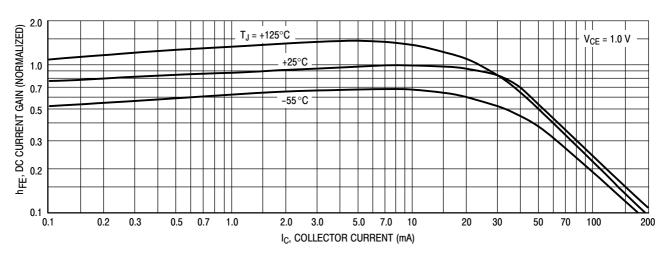


Figure 13. DC Current Gain

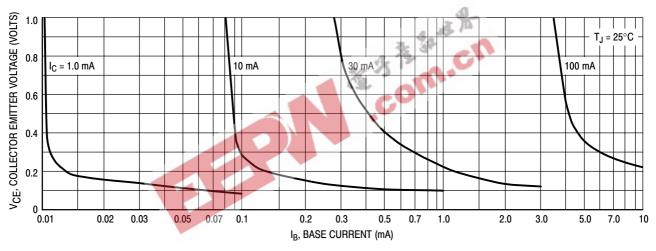


Figure 14. Collector Saturation Region

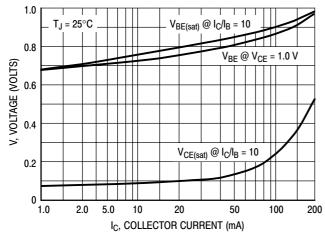


Figure 15. "ON" Voltages

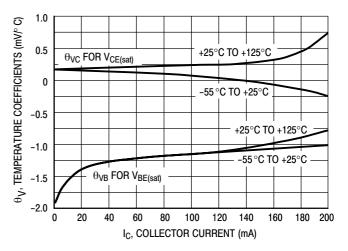
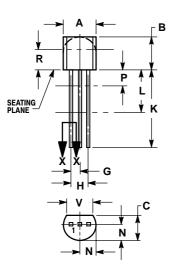


Figure 16. Temperature Coefficients

PACKAGE DIMENSIONS

TO-92 (TO-226) CASE 29-11 **ISSUE AM**



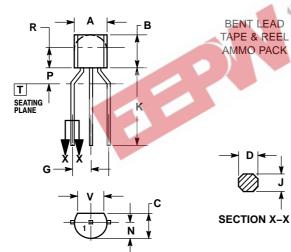
STRAIGHT LEAD **BULK PACK**



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.
 CONTOUR OF PACKAGE BEYOND DIMENSION R IS UNCONTROLLED.
- LEAD DIMENSION IS UNCONTROLLED IN P AND BEYOND DIMENSION K MINIMUM.

		INCHES		MILLIMETERS	
	DIM	MIN	MAX	MIN	MAX
	Α	0.175	0.205	4.45	5.20
	В	0.170	0.210	4.32	5.33
	С	0.125	0.165	3.18	4.19
	D	0.016	0.021	0.407	0.533
	G	0.045	0.055	1.15	1.39
	Н	0.095	0.105	2.42	2.66
•	J	0.015	0.020	0.39	0.50
	K	0.500		12.70	
•	L	0.250		6.35	
	N	0.080	0.105	2.04	2.66
v	P		0.100		2.54
X	R	0.115	and the second	2.93	
	V	0.135		3.43	
爱为		·C	n		
	NOTES			TO! FD4	
	1. DII	 DIMENSIONING AND TOLERANCING P 			



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- CONTOUR OF PACKAGE BEYOND
 DIMENSION R IS UNCONTROLLED.
 LEAD DIMENSION IS UNCONTROLLED IN P
- AND BEYOND DIMENSION K MINIMUN

	MILLIMETERS			
DIM	MIN	MAX		
Α	4.45	5.20		
В	4.32	5.33		
c	3.18	4.19		
D	0.40	0.54		
G	2.40	2.80		
7	0.39	0.50		
K	12.70			
N	2.04	2.66		
P	1.50	4.00		
R	2.93			
٧	3.43			

STYLE 1:

PIN 1. EMITTER

COLLECTOR

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